

1. Scope

This specification is applies to Multilayer Ceramic Chip Capacitor (MLCC) for use in electric equipment for the voltage is ranging from 100V to 5KV.

The MLCC support for Lead-Free wave and reflow soldering, and electrical characteristic and reliability are same as before. (This product compliant with the RoHS.)

2. Parts Number Code

| С | 1206 | Х | 331 | K | 102 | Т |
|-----|------|-----|-----|-----|-----|-----|
| (1) | (2) | (3) | (4) | (5) | (6) | (7) |

(1)Product

| Product Code | |
|--------------|-----------------------------------|
| С | Multilayer Ceramic Chip Capacitor |
| | |

(2)Chip Size

| ` / | | |
|------|--------------|-----------------|
| Code | Length×Width | unit : mm(inch) |
| 0201 | 0.60× 0.30 | (.024× .011) |
| 0402 | 1.00× 0.50 | (.039× .020) |
| 0603 | 1.60× 0.80 | (.063× .031) |
| 0805 | 2.00× 1.25 | (.079× .049) |
| 1206 | 3.20× 1.60 | (.126× .063) |
| 1210 | 3.20× 2.50 | (.126× .098) |
| 1808 | 4.60× 2.00 | (.181× .079) |
| 1812 | 4.60× 3.20 | (.181× .125) |
| 1825 | 4.60× 6.35 | (.181× .250) |
| 2208 | 5.70× 2.00 | (.220× .197) |
| 2211 | 5.70× 2.80 | (.220× .110) |
| 2220 | 5.70× 5.00 | (.220× .197) |
| 2225 | 5.70× 6.35 | (.220× .250) |

(3)Temperature Characteristics

| Code | Temperature | Temperature | Temperature |
|------|----------------|---------------|---------------|
| | Characteristic | Range | Coefficient |
| Ν | NPO | -55°℃~+125°℃ | 30 ppm/°C |
| L | SL | -30°C ~+85°C | +350~-1000ppm |
| X | X7R | -55℃~+125℃ | ± 15% |
| В | X5R | -55°C ~+85°C | ± 15% |
| S | X6S | -55°C ~+105°C | ± 22% |
| Υ | Y5V | -30°C ~+85°C | +22/-82% |
| Z | Z5U | +10°℃~+85°℃ | +22/-56% |
| E | Y5U | -30°C ~+85°C | +22/-56% |
| | | | |

(4)Capacitance unit :pico farads(pF)

| · · · - | |
|---------|--------------------------|
| Code | Nominal Capacitance (pF) |
| 5R0 | 5.0 |
| 120 | 12.0 |
| 331 | 330.0 |
| 222 | 2,200.0 |
| 683 | 68,000.0 |
| 474 | 470,000.0 |
| 105 | 1,000,000.0 |
| 106 | 10,000,000.0 |

**. If there is a decimal point, it shall be expressed by an

(5) Capacitance Tolerance

| Code | Tolerance | Nominal Capacitance |
|------|-----------|---------------------|
| В | ± 0.10 pF | Less Than 10 pF |
| С | ± 0.25 pF | (Include 10 pF) |
| D | ± 0.50 pF | - |
| F | ± 1.00 pF | _ |
| F | ± 1.00 % | More Than 10 pF |
| G | ± 2.00 % | _ |
| J | ± 5.00 % | - |
| K | ± 10.0 % | _ |
| М | ± 20.0 % | _ |
| Z | +80/-20 % | _ |

(6)Rated Voltage

| Code | Rated Voltage (Vdc) |
|------|---------------------|
| 101 | 100 |
| 201 | 200 |
| 251 | 250 |
| 501 | 500 |
| 631 | 630 |
| 102 | 1,000 |
| 202 | 2,000 |
| 252 | 2,500 |
| 302 | 3,000 |
| 502 | 5,000 |
| | |

(7)Tapping

| Code | Type | |
|------|-------------|--|
| Т | Tape & Reel | |
| В | Bulk | |

English capital letter R

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3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

| Class | Characteristic | Tolera | ance | Nominal Capacitance |
|-------|----------------|-------------------------------|---------------|-------------------------------|
| I | NPO / SL | Less Then 10 pF B (± 0.10 pF) | | 0.5,1,1.5,2,2.5,3 |
| | | | C (± 0.25 pF) | 0.5,1,1.5,2,2.5,3,3.5,4,4.5,5 |
| | | | D (± 0.50 pF) | 5,6,7,8,9,10 |
| | | | F (± 1.00 pF) | 6,7,8,9,10 |
| | | More Than 10 pF | F (±1.00 %) | E-12, E-24 series |
| | | | G (±2.00 %) | |
| | | | J (± 5.00 %) | |
| | | | K (± 10.0 %) | |
| П | X7R/X5R/X7E | K (± 10.0 %), | M (± 20.0 %) | E-3, E-6 series |
| | Y5V | M (± 20.0 %), Z | Z(+80/-20 %) | E- 3 series |
| | Z5U | | | |
| | Y5U | | | |

3.2 E series(standard Number)

| • | | | - | | | | | | | | | |
|--------------|-----|-------------------------|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|
| Standard No. | | Application Capacitance | | | | | | | | | | |
| E- 3 | | 1.0 2.2 4.7 | | | | | | | | | | |
| E- 6 | 1 | .0 | 1 | .5 | 2 | .2 | 3 | .3 | 4 | .7 | 6 | .8 |
| E-12 | 1.0 | 1.2 | 1.5 | 1.8 | 2.2 | 2.7 | 3.3 | 3.9 | 4.7 | 5.6 | 6.8 | 8.2 |
| E-24 | 1.0 | 1.2 | 1.5 | 1.8 | 2.2 | 2.7 | 3.3 | 3.9 | 4.7 | 5.6 | 6.8 | 8.2 |
| | 1.1 | 1.3 | 1.6 | 2.0 | 2.4 | 3.0 | 3.6 | 4.3 | 5.1 | 6.2 | 7.5 | 9.1 |

4. Operation Temperature Range

| Class | Characteristic | Temperature Range | Reference Temp. |
|-------|----------------|-------------------|-----------------|
| I | NPO | -55°C ~ +125°C | 25 ℃ |
| | SL | -25°C ~ +125°C | 25 ℃ |
| П | X7R | -55℃ ~ +125℃ | 25℃ |
| | X5R | -55℃ ~ +85℃ | 25 ℃ |
| | X6S | -55°C ~ +105°C | 25 ℃ |
| | Y5V | -30℃ ~ +85℃ | 25 ℃ |
| | Z5U | +10℃ ~ +85℃ | 25 ℃ |
| | Y5U | -30°C ~ +85°C | 25 ℃ |
| | Other | -25°C ~ +85°C | 25 ℃ |

5. Storage Condition

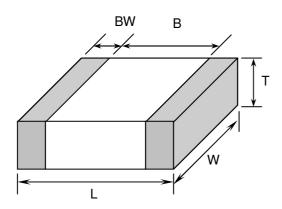
Storage Temperature : 5 to 40° C Relative Humidity : 20 to 70 % Storage Time : 6 months max.

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6. Dimensions

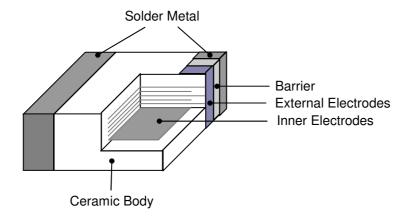
6.1 Configuration and Dimension:



Unit:mm

| TYPE | L | W | Т | B (min) | BW (min) |
|------|------------|------------|------------|---------|----------|
| 1206 | 3.20± 0.30 | 1.60± 0.20 | 1.25± 0.15 | 1.50 | 0.30 |

6.2 Termination Type :





7. Performance

| No. | Item | | S | pecification | Test Condition | | |
|-----|----------------------|----------------------|-----------------|---------------------------|--|--|--|
| 1 | Visua | ıl | No abnormal | exterior appearance | Visual inspection | | |
| 2 | Dimens | ion | See Page 3 | | Visual inspection | | |
| 3 | Insulati Resista | 1 ' | | | V≤500V, Rated Voltage V>500V, Applied 500Vdc Charge Time: 60sec. Is applied less than 50mA current. | | |
| 4 | Capacitance | Class | Within The Spo | ecified Tolerance | Class I: | | |
| | | I NPO/SL Class | Within The Sn | ecified Tolerance | NPO/SL Capacitance Frequency Voltage | | |
| | | П | | | C≤100pF 1MHz±10% 1.0±0.2Vrms C>100pF 1KHz±10% | | |
| 5 | Q | Class | More Than 30 | | Class Ⅱ: | | |
| | | I I | | : Q≥400+20C | Frequency Voltage | | |
| | Tan δ | NPO/SL | (C : Capacita | | X7R 1KHz±10% 1.0±0.2Vrms | | |
| | ian o | Class II | Char. X7R | Maximum 2.5% | Z5U/Y5U 1KHz±10% 1.0±0.2Vrms Perform a heat temperature at 150±5°C for | | |
| | | 11 | Z5U/Y5U | 4.0% | 30min. then place room temp. for 24±2hr. | | |
| | Withstan | dina | | breakdown or | V<500V : 200% Rated Voltage | | |
| 6 | Voltag | - | mechanical b | | 500V≦V<1000V: 150% Rated Voltage | | |
| | | , - | | | 1000 ≦ V :120% Rated Voltage | | |
| | | | | | for 1~5 sec. Current is limited to less than | | |
| | | | | | 50mA. | | |
| | | | | | Withstanding voltage testing requires immersion of the element in a isolation fluid prevent arcing on the chip surface, at voltage over 1000Vdc. | | |
| 7 | Temperature | Class I | Char. Temp. F | Range Cap. Change(%) | Class I: | | |
| | Capacitance | | NPO -55°C ~+ | | [C2-C1/C1(T2-T1)] × 100% | | |
| | Coefficient | | SL -30°C∼+ | | | | |
| | | Class | Char. Temp. F | | (C2-C1)/C1 × 100% | | |
| | | П | X7R -55°C ~⊣ | | T1: Standard temperature (25°C) T2: Test temperature | | |
| | | | Y5U -30°C ~ | +85°C | C1:Capacitance at standard temperature(25°C) | | |
| | | | Z5U +10°C ~ | +85°C +22% ~-56% | C2: Capacitance at test temperature (T2) | | |
| 8 | Adhesive S | | | of peeling shall occur on | A 5N·f (≒0.5Kg·f) pull force shall be applied | | |
| | of Termin | ation | the terminal el | ectrode. | for 10± 1 second. | | |
| | | | | | | | |
| | | | | | ₹ 5N·f | | |
| | | | | | 5111 | | |
| | | Π_ | | | | | |
| 9 | Resistance | Appear- | No mechanica | I damage shall be occur. | Bending shall be applied to the 1.0 mm with | | |
| | to | ance | | NI . | 1.0 mm/sec. _R230 ↓ | | |
| | Flexure of Substrate | C-Meter | Capacitance C | | → Bending | | |
| | oi Substrate | | Char. | Cap. Change | Limit | | |
| | | | NPO | ≤ ± 5.0% | C Meter | | |
| | | | SL | ≤ ± 5.0% | < → < → 45±1mm 45±1mm | | |
| | | | X7R | ≤ ± 12.5% | 40±111111 | | |
| | | | Y5U/Z5U | ≤ ± 30.0% | | | |



| No. | Ite | m | | Speci | fication | | | Test (| Condition | | |
|-----|-------------------|--------------------------|---|-------------------------------|--|--|---|------------------------------------|--------------|--------------|-----|
| 10 | Solder | ability | | | he terminal surface | | | Temperature | | | |
| | | | is to be soldered newly, so metal part does not come out or dissolve. | | | Dip Time: 5 ± 0.5 sec. Immersing Speed: 25±10% mm/s | | | | | |
| | | | 40031 | | or dissolve . | | Solder : H63A | | | | |
| | | | | | | | Flux | :Rosin | | | |
| | D '. I | A | NI | | | | Prehea | | | | |
| 11 | Resistance To | ance | NO ME | echanicai dar | nage shall occur. | Class | | rs at | | | |
| | Soldering Heat | Capacit- ance | | aracteristic | Cap. Change | | eatme neasur | nt at 150 +0/-1 e. | 0°C before | e initial | |
| | rioat | S. 100 | Class (NPO/ | | Within ± 2.5% or ±0.25pFwhichever | | Prehea | at : At 150± 10 | ℃ For 60~ | 120sec. | |
| | | | (141 0/ | OL) | is larger of initial | | | older Tempera | | 0± 5℃ | |
| | | | 01 | V7D | value | | | ne:10 ± 1sec | | m/o | |
| | | | Class | X7R Z5U/Y5U | Within ± 10% Within ± 20% | | Solder | sing Speed : 2 : H63A | 3±10% IIII | 11/5 | |
| | | Q | | | fied initial value | | Flux | :Rosin | | | |
| | | Class I Tan δ | To sati | sty the speci | fied initial value | M | 1easur | e at room tem | perature at | ter cooling | for |
| | | Class II | 10 oati | ory and open | mod miliai valao | | | I : 24 ± 2 Ηοί | | _ | |
| | | Insulation Resistance | | sfy the spec | fied initial value | | Class | i∏ : 48 ± 4 Hoι | ırs | | |
| | | | | sfy the spec | fied initial value | | | | | | |
| 12 | Tempera ture | Appear- ance | No me | chanical dar | nage shall occur | | Class ☐ capacitor shall be set for 48± 4 hours a room temperature after one hour heat treatmen | | | | |
| | Cycle | Capacit- | | aracteristic | Cap. Change | a | t 150 - | -0/-10 °C befor | e initial me | easure. | |
| | | ance | Class (NPO/ | | Within ± 2.5% or ±0.25pFwhichever | | Canac | itor shall be su | hiected to | five cycles | of |
| | | | (INFO) | SL) | is larger of initial | | | nperature cycl | | | Oi |
| | | | Class | X7R | value Within ± 7.5% | | Step | Temp.(| | Time(min) | |
| | | | Uiass ∏ | Z5U/Y5U | Within ± 20% | | 2 | Min Rated Ter 25 | np. +0/-3 | 30 | _ |
| | | Q | To sati | sfy the spec | fied initial value | | 3 | Max Rated Te | mp. +3/-0 | 30 | |
| | | Class I Tan δ | To ooti | of the appear | fied initial value | | 4 | 25 | • | 3 | |
| | | Class II | 10 Sali | isiy ille speci | med iriiliai vaide | Ν | | e at room temp | perature at | ter cooling | for |
| | | Insulation | | sfy the spec | fied initial value | | | i | | | |
| | | Resistance | | | | | | the capacitor | on P.C. bo | ard shown | in |
| | | - | | | | | Fig 2. | before testing. | | | |
| 13 | Humidity | Appear- ance | No me | chanical dar | nage shall occur | | | capacitor sha temperature a | | | ırs |
| | | Capacit- | | racteristic | Cap. Change | | | nt at 150+0/-1 | | | |
| | | ance | Class | | Within ± 5.0% or | | neasur | | C | | |
| | | | (NPO/ | SL) | ±0.5pF whichever is larger of initial value | | | rature : 40± 2° re Humidity : 9 | | H | |
| | | | Class | X7R | Within ± 15% | | | me: 500 + 12 | | • | |
| | | | П | | Within ± 30% | | 1 | | | itau aaaliaa | f |
| | | Q Class I | | Γhan 30pF : (& Below: Ω ≥ | Q ≧ 350 ≧ 275 + 2.5×C | IV | | e at room temp s I :24 ± 2Hr | | ter cooling | 101 |
| | | Tan δ | | nar. | <u>273 + 2.5xC</u> Maximum | 1 | | s | | | |
| | | Class II | X | 7R | 5.0% | | وماطء | the conceite | on DC b- | ard share | in |
| | | Inquilatia : | | /Y5U | 5.0% | | | the capacitor before testing. | | aru Sriown | 111 |
| | | Insulation Resistance | - | | Ω whichever is | | .g | | | | |
| | | | 2 | | | | | | | | |

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HVC-008-0807

| No. | Ite | m | Specifi | cation | | Test Condition | | |
|-----|-----------|---------------|---------------------------|---------------------------------------|-----|--|--|--|
| 14 | High | Appear- | No mechanical dam | age shall occur | | ass | _ | |
| | • | ance | | T | | ollowing table) is app | | |
| | Load | Capacit- | Characteristic | Cap. Change | - | maximum operation temperature ±3℃ then | | |
| | | ance | Class I | Within ±3.0% or | | | urs at room temperature | |
| | | | (NPO/SL) | ± 0.3pFwhichever is larger | | d the initial measurer | ment shall be | |
| | | | Class X7R | Within ± 15% | 1 | conducted. | | |
| | | | II Z5U/Y5U | Within ± 30% | Ap | oplied Voltage : | | |
| | | Q | More Than 30pF : Q | ≥ 350 | | Rated Voltage | Applied Voltage | |
| | | Class I | 30pF & Below:Q ≥ 3 | | | V≤250Vdc | 150%Rated Voltage | |
| | | Tan δ | Char. | maximum | | Less Than 1KVdc | 120%Rated Voltage | |
| | | Class II | X7R | 5.0% | - | More Than | 100%Rated Voltage | |
| | | Inquiation | Z5U/Y5U 1,000MΩ or 50/C Ω | 5.0% | - | 1KVdc(include 1KV) | 100%haleu vollage | |
| | | Resistance | - | (C in Farad) | | | | |
| | | i losistarioc | Sinanci. | (O III I alaa) | | 1210/100V capacitance more than 1.0uF applied voltage of 120% rated voltage Temperature : max. operation temperature Test Time : 1000 +12/-0Hr | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | rrent Applied: 50 m/ | | |
| | | | | | | | erature after cooling for | |
| | | | | | Cla | ass I : 24 ± 2 Hours | | |
| | | | | | | ass II: 48 ± 4 Hours | | |
| 15 | Vibration | Appear- | No mechanical dam | age shall occur | | | n P.C. Board shown in | |
| | | ance | 01 | | F | ig 2. before testing. | | |
| | | Capacit- | Characteristic | Cap. Change | | ibrata tha aspasitar u | with amplitude of 1 5mm | |
| | | ance | Class I (NPO/SL) | Within ± 2.5% or ± 0.25pFwhichever | | | vith amplitude of 1.5mm uencies from 10Hz to | |
| | | | (INI O/SL) | is larger | | 5Hz and back to 10H | | |
| | | | Class X7R | Within ± 7.5% | | | | |
| | | | II Z5U/Y5U | Within ± 20% | | | each in 3perpendicular | |
| | | Q | To satisfy the specifi | ed initial value | dir | ections. | | |
| | | Class I | | | | | | |
| | | Tan δ | To satisfy the specifi | ed initial value | | | | |
| | | Class II | Ta ankata da a a a a a | and installation of the | - | | | |
| | | | To satisfy the specifi | ea initiai value | | | | |
| | | Resistance | | | | | | |

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Fig.1
P.C. Board for Bending Strength Test

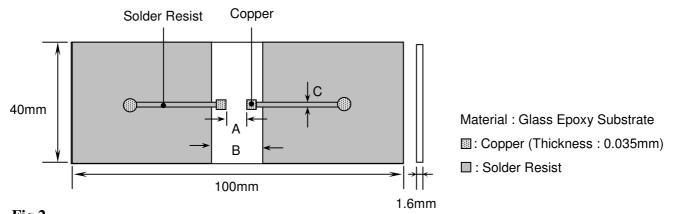
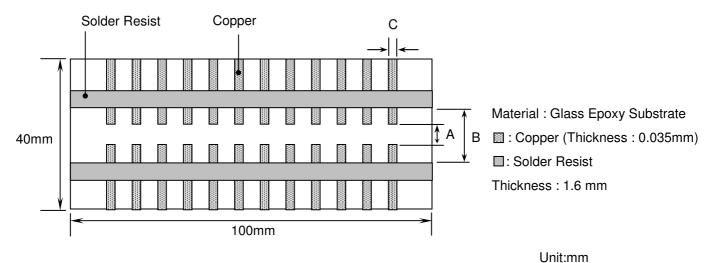


Fig.2 Test Substrate



| Type | Α | В | С |
|------|-----|-----|-----|
| 0201 | 0.2 | 0.9 | 0.4 |
| 0402 | 0.5 | 1.5 | 0.6 |
| 0603 | 1.0 | 3.0 | 1.0 |
| 0805 | 1.2 | 4.0 | 1.6 |
| 1206 | 2.2 | 5.0 | 2.0 |
| 1210 | 2.2 | 5.0 | 2.9 |
| 1808 | 3.5 | 7.0 | 2.5 |
| 1812 | 3.5 | 7.0 | 3.7 |
| 2208 | 4.5 | 8.0 | 2.5 |
| 2211 | 4.5 | 8.0 | 3.0 |
| 2220 | 4.5 | 8.0 | 5.6 |

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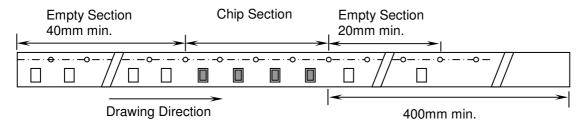


8. Packing

8.1 Bulk Packing

According to customer request.

8.2 Chip Capacitors Tape Packing



8.3 Material And Quantity

| Tape | 0201 | 0402 | 0603/ | 0805 |
|----------|-----------------|-----------------|----------------|----------------|
| Material | T≦0.33mm | T≦0.55mm | T≦0.90mm | T>0.90mm |
| Paper | 15,000 pcs/Reel | 10,000 pcs/Reel | 4,000 pcs/Reel | NA |
| Plastic | NA | NA | NA | 3,000 pcs/Reel |

| Tape | | 1206 | 1210/1808 | | |
|----------|----------------|---------------------|----------------|---------------|---------------|
| Material | T≦0.90mm | 0.90mm < T ≤ 1.25mm | T>1.25mm | T≦1.25mm | T>1.25mm |
| Paper | 4,000 pcs/Reel | NA | NA | NA | NA |
| Plastic | NA | 3,000 pcs/Reel | 2,000 pcs/Reel | 3000 pcs/Reel | 2000 pcs/Reel |

| Tape | 1812/1825 | /2211/2220 | 22 | 2225 | | |
|----------|-------------------|--------------|---------------|--------------|---------------|--|
| Material | T≦2.20mm T>2.20mm | | T≦2.20mm | T≦2.20mm | | |
| Paper | NA | NA | NA | NA | NA | |
| Plastic | 1000 pcs/Reel | 700 pcs/Reel | 1000 pcs/Reel | 400 pcs/Reel | 1000 pcs/Reel | |

NA: Not Available

8.4 Cover Tape Reel Off Force

9.4.1 Peel-Off Force

 $5 g \cdot f \leq Peel-Off Force \leq 70 g \cdot f$

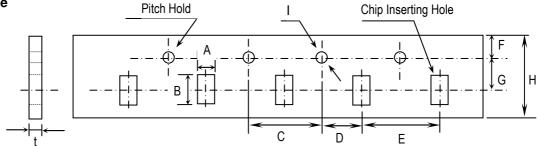
9.4.2 Measure Method



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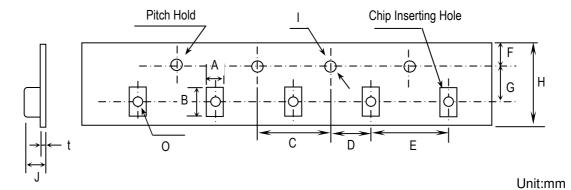


Unit:mm

| TYPE | Α | В | С | D | E |
|------|-----------|-----------|-----------|------------|-----------|
| 0201 | 0.37± 0.1 | 0.67± 0.1 | 4.00± 0.1 | 2.00± 0.05 | 2.00± 0.1 |
| 0402 | 0.61± 0.1 | 1.20± 0.1 | | | |
| 0603 | 1.10± 0.2 | 1.90± 0.2 | | | 4.00± 0.1 |
| 0805 | 1.50± 0.2 | 2.30± 0.2 | | | |
| 1206 | 1.90± 0.2 | 3.50± 0.2 | | | |
| 1210 | 2.90± 0.2 | 3.60± 0.2 | | | |

| TYPE | F | G | Н | | t |
|------|------------|------------|-----------|-----------------|-----------|
| 0201 | 1.75± 0.10 | 3.50± 0.05 | 8.0± 0.30 | φ 1.50 +0.10/-0 | 1.10 max. |
| 0402 | | | | | |
| 0603 | | | | | |
| 0805 | | | | | |
| 1206 | | | | | |
| 1210 | | | | | |

8.6 Plastic Tape



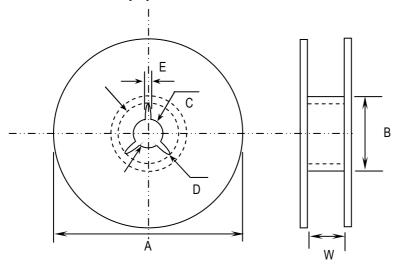
| Type | Α | В | С | D | E | F |
|------|---------|---------|----------|-----------|----------|-----------|
| 0805 | 1.5±0.2 | 2.3±0.2 | 4.0± 0.1 | 2.0± 0.05 | 4.0± 0.1 | 1.75± 0.1 |
| 1206 | 1.9±0.2 | 3.5±0.2 | | | | |
| 1210 | 2.9±0.2 | 3.6±0.2 | | | | |
| 1808 | 2.5±0.2 | 4.9±0.2 | | | | |
| 1812 | 3.6±0.2 | 4.9±0.2 | | | 8.0± 0.1 | |
| 1825 | 6.9±0.2 | 4.9±0.2 | | | | |
| 2208 | 2.5±0.2 | 6.1±0.2 | | | | |
| 2211 | 3.2±0.2 | 6.1±0.2 | | | | |
| 2220 | 5.4±0.2 | 6.1±0.2 | | | | |
| 2225 | 6.9±0.2 | 6.1±0.2 | | | | |



| Туре | G | Н | I | J | t | 0 |
|------|-----------|------------|--------------|----------|----------|-----------|
| 0805 | 3.5± 0.05 | 8.0± 0.3 | φ 1.5+0.1/-0 | 3.0 max. | 0.3 max. | 0.15 min. |
| 1206 | | | | | | |
| 1210 | | | | | | |
| 1808 | 5.5± 0.05 | 12.0 ± 0.3 | | 4.0 max. | | |
| 1812 | | | | | | |
| 1825 | | | | | | |
| 2208 | | | | | | |
| 2211 | | | | | | |
| 2220 | | | | | | |
| 2225 | | | | | | |

8.7 Reel Dimensions

Reel Material : Polystyrene



Unit:mm

| Type | Α | В | С | D | E | W |
|------|-------------------|------------------|-------------------|-------------------|---------|----------|
| 0201 | φ 382 max | arphi 50 min | φ 13± 0.5 | φ 21± 0.8 | 2.0±0.5 | 10± 0.15 |
| 0402 | | | | | | |
| 0603 | | | | | | |
| 0805 | | | | | | |
| 1206 | | | | | | |
| 1210 | | | | | | |
| 1808 | φ 178±0.2 | φ 60±0.2 | | | | 13±0.3 |
| 1812 | | | | | | |
| 1825 | | | | | | |
| 2208 | | | | | | |
| 2211 | | | | | | |
| 2220 | | | | | | |
| 2225 | | | | | | |

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Precautionary Notes:

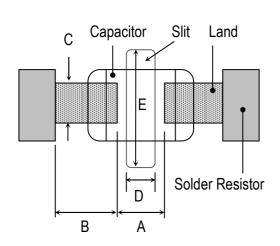
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40 °C and 70%RH. We recommend that the capacitors be used within 6 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering .

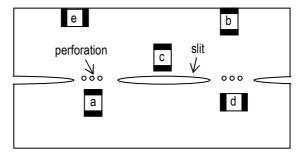


| EIA Codo | Chip (mm) | | Land (mm) | | | | |
|----------|-----------|------|-----------|---------|---------|---------|---------|
| EIA Code | L | W | Α | В | С | D | Е |
| 0201 | 0.60 | 0.30 | 0.2~0.3 | 0.2~0.4 | 0.2~0.4 | | |
| 0402 | 1.00 | 0.50 | 0.3~0.5 | 0.3~0.5 | 0.4~0.6 | | 1 |
| 0603 | 1.60 | 0.80 | 0.4~0.6 | 0.6~0.7 | 0.6~0.8 | | 1 |
| 0805 | 2.00 | 1.25 | 0.7~0.9 | 0.6~0.8 | 0.8~1.1 | | 1 |
| 1206 | 3.20 | 1.60 | 2.2~2.4 | 0.8~0.9 | 1.0~1.4 | 1.0~2.0 | 3.2~3.7 |
| 1210 | 3.20 | 2.50 | 2.2~2.4 | 1.0~1.2 | 1.8~2.3 | 1.0~2.0 | 4.1~4.6 |
| 1808 | 4.60 | 2.00 | 2.8~3.4 | 1.8~2.0 | 1.5~1.8 | 1.0~2.8 | 3.6~4.1 |
| 1812 | 4.60 | 3.20 | 2.8~3.4 | 1.8~2.0 | 2.3~3.0 | 1.0~2.8 | 4.8~5.3 |
| 1825 | 4.60 | 6.35 | 2.8~3.4 | 1.8~2.0 | 5.1~5.8 | 1.0~4.0 | 7.1~8.3 |
| 2208 | 5.70 | 2.00 | 4.0~4.6 | 2.0~2.2 | 1.5~1.8 | 1.0~4.0 | 3.6~4.1 |
| 2211 | 5.70 | 2.80 | 4.0~4.6 | 2.0~2.2 | 2.0~2.6 | 1.0~4.0 | 4.4~4.9 |
| 2220 | 5.70 | 5.00 | 4.0~4.6 | 2.0~2.2 | 3.5~4.8 | 1.0~4.0 | 6.6~7.1 |
| 2225 | 5.70 | 6.35 | 4.0~4.6 | 2.0~2.2 | 5.1~5.8 | 1.0~4.0 | 7.1~8.3 |

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended. Susceptibility to stress is in the order of: a>b>c and d>e



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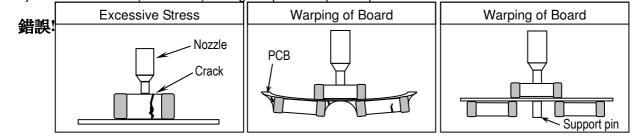


2.3 Layout Recommendation

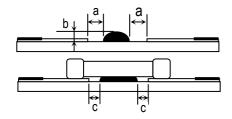
| Example | Use of Common Solder Land | Solder With Chassis | Use of Common Solder Land With Other SMD |
|----------------|--|--------------------------------|---|
| Need to Avoid | Chip Solder Adhesive PCB Solder Land | Chassis Excessive Solder a | Solder Land |
| Recommendation | Chip Solder Resist Adhesive PCB Solder Land | Solder Resist $\alpha > \beta$ | |

3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



3.2 Amount of Adhesive



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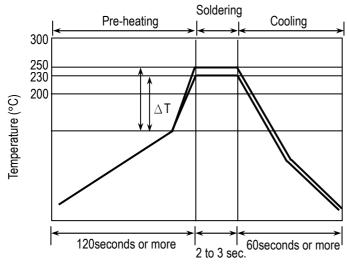


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to $250\,^{\circ}$ C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



| Soldering Method | Change in Temp.($^{\circ}$ C) |
|------------------|--|
| 1206 and Under | $\Delta T \le 100 \sim 130 \text{ max}.$ |

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
 - a. Flux flows to easily
 - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

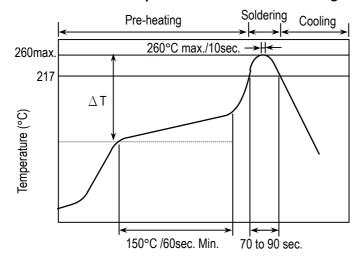
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) between the solvent and the chips must be less than 100 °C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed $3\,^{\circ}\text{C/Sec}$.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



※ The cycles of soldering : Twice (max.)

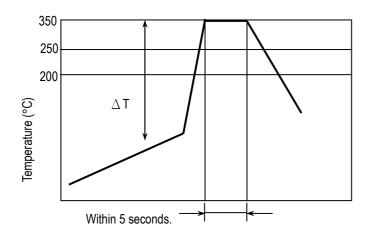
| Soldering Method | Change in Temp.(°C) | |
|------------------|----------------------|--|
| 1206 and Under | ∆T ≦ 190 °C | |
| 1210 and Over | ∆T ≦ 130 °C | |

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4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



| Soldering Method | Change in Temp.(°C) |
|------------------|------------------------------------|
| 1206 and Under | Δ T \leq 190 $^{\circ}$ C |
| 1210 and Over | Δ T \leq 130 $^{\circ}$ C |

How to Solder Repair by Solder Iron

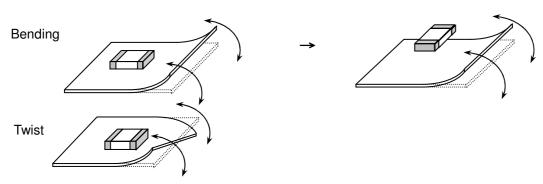
- 1) Selection of the soldering iron tip
 - The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.
- 2) recommended solder iron condition
 - a.) Preheat the substrate to (60 ℃ to 120 ℃) on a hot plate. Note that due to the heat loss, the actual setting of the hot plate may have to be higher. (For example 100 ℃ to 150 ℃)
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350 ℃., and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
 - f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
 - g.) After soldering operation, let the products cool down gradually in the room temperature.

5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.

Higher potential of crack





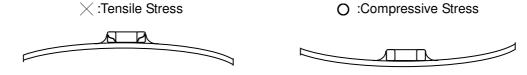
5.2 There is a potential of crack if board is warped due to excessive load by check pin



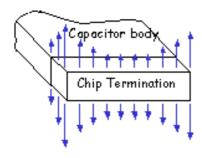
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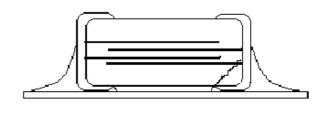


- 5.3 Mechanical stress due to warping and torsion.
 - (a) Crack occurrence ratio will be increased by manual separation.
 - (b) Crack occurrence ratio will be increased by tensile force, rather than compressive force.



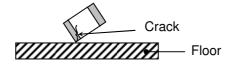
Capacitor Stress Analysis



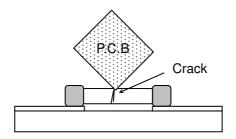


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40 °C and under humidity of 20 to 75% RH. The shelf life of capacitors is 6 months.

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